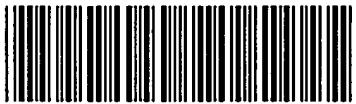


**Search Notes****Application/Control No.**

10/657,901

**Examiner**

Chris C. Chu

**Applicant(s)/Patent under Reexamination**

SARAN ET AL.

**Art Unit**

2815

**SEARCHED**

Class	Subclass	Date	Examiner
257	E23.02, E21.523, E21.59 & 676	3/28/2005	C.C.
257	E23.026	3/28/2005	C.C.
257	687 & 690	3/28/2005	C.C.
257	778 - 784	3/28/2005	C.C.
257	786 & 789	3/28/2005	C.C.
257	798 & 738	3/28/2005	C.C.
257	701	3/28/2005	C.C.
438	612	3/28/2005	C.C.

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched in US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; and IBM_TDB;	3/28/2005	C.C.

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner